

PIXEL2012 Inawashiro, Japan 6th International Workshop on Semiconductor Pixel Detectors for Particles and Imaging, September 3-7, 2012



Upgrade of the ALICE ITS

Details on the Upgrade proposal

Stefan Rossegger on behalf of the ALICE ITS collaboration 3rd of September, 2011



Overview



Participating Institutes



- ALICE at CERN
- Current ITS
 - Design and Performance
- ITS upgrade
 - Motivation
 - Key Improvements
 - Pixel Technologies
 - Mechanical Support
- Timeline



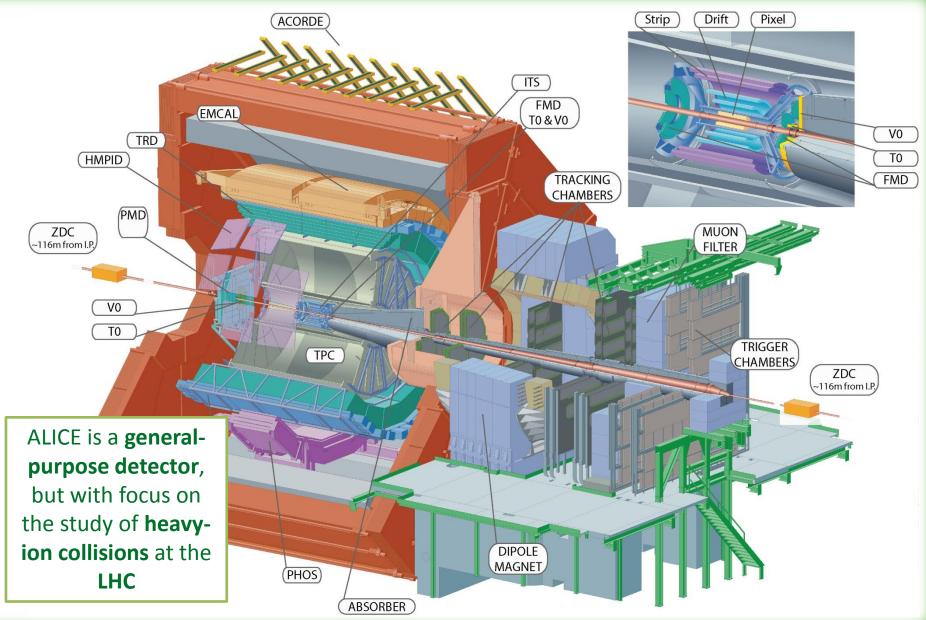
CERN Geneva European Organization for Nuclear Research China Wuhan Institute of Particle Physics, Central China Normal University (CCNU) Czech Republic Řež u Prahy Nuclear Physics Institute of the ASCR France IN2P3 Strasbourg Institut Hubert Curien, Université Louis Pasteur, IN2P3-CNRS Italy INFN Bari Sezione INFN e Dipartimento dell'Università e del Politecnico di Bari Italy INFN Cagliari Sezione INFN e Dipartimento di Fisica dell'Università di Cagliari Italy INFN Catania Sezione INFN e Dipartimento di Fisica dell'Università di Catania Italy INFN Frascati Laboratori Nazionali di Frascati (LNF) Italy INFN Legnaro Laboratori Nazionali di Legnaro (LNL) Italy INFN Padova Sezione INFN e Dipartimento di Fisica e Astronomia dell'Università di Padova Italy INFN Roma Sezione INFN e Dipartimento di Fisica dell'Università "La Sapienza" di Roma Italy INFN Torino Sezione INFN e Dipartimento di Fisica dell'Università di Torino Italy INFN Trieste Sezione INFN e Dipartimento di Fisica dell'Università di Trieste Korea Seoul Yonsei University Pakistan Islamabad Faculty of Sciences, COMSATS, Institute of Information Technology Russia St. Petersburg Institute of Physics, St. Petersburg State University Slovakia Košice Slovak Academy of Sciences, IEP UK STFC Birmingham University of Birmingham UK STFC Warrington STFC Daresbury Laboratory UK STFC Chilton Rutherford Appleton Laboratory Ukraine Kharkov Ukrainian Academy of Sciences, KIPT-KFTI Ukraine Kharkov Scientific Research Technological Institute of Instrument Engineering SRTIIE Ukraine Kiev Bogolyubov Institute for Theoretical Physics (BITP)



03/09/2012

ALICE – A Large Ion Collider Experiment





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ALICE – Detector Upgrade



Motivation

- Improve tracking and low p_t vertexing while preserving the excellent particle-identification of the current detector
- Readout all Pb-Pb events at an interaction rate of 50 kHz

Upgrade targets:

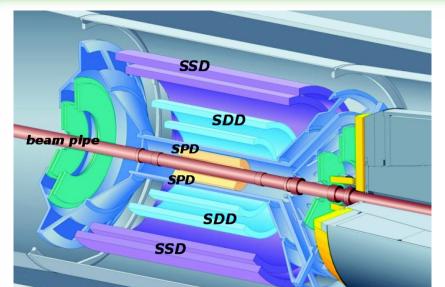
- new, smaller radius, beam pipe
- new ITS (Inner Tracking System)
- high-rate upgrade for the readout of the TPC, TRD, TOF, PHOS, Muon-Arm, Online-systems and Trigger detectors

• Target for installation and commissioning LS2 (2018)



ALICE ITS (Inner Tracking System)





(current detector)

Current ITS consists of 6 concentric barrels of silicon detectors

3 different technologies

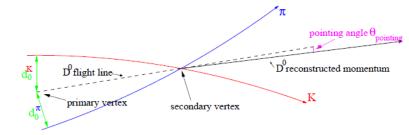
- 2 layers of silicon pixel (SPD)
- 2 layers of silicon drift (SDD)
- 2 layers of silicon strips (SSD)

Layer/ Ty	уре	Radius [cm]	Length [cm]	Number of modules	Active area per module [mm ²]	Nom. resolution rφ x z [μm]	Material budget X/X ₀ [%]
Beam pi	ipe	2.94	-	-	-	-	0.22
1 / Pixe	el	3.9	28.2	80	12.8 × 70.7	12 × 100	1.14
2 / Pixe	el	7.6	28.2	160	12.8 × 70.7	12 × 100	1.14
Thermal SI	hield	11.5	-	-	-	-	0.65
3 / Dri	ft	15.0	44.4	84	70.2 x 75.3	35 × 25	1.13
4 / Dri	ft	23.9	59.4	176	70.2 x 75.3	35 × 25	1.26
Thermal SI	hield	31.0	-	-	-	-	0.65
5 / Stri	ip	38.0	86.2	748	73.0 x x40.0	30 × 830	0.83
6 / Stri	ір	43.0	97.8	950	73.0 x x40.0	20 × 830	0.83

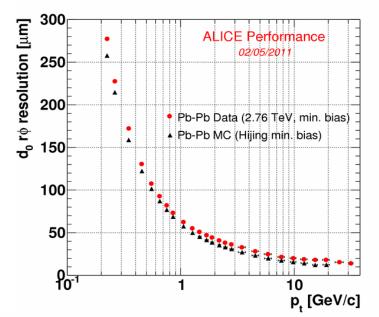
ALICE ITS (current) performance



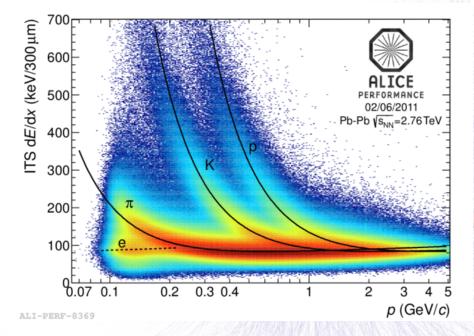
 The Identification of secondary vertices relies on the impact parameter d₀ (in rφ and z)



impact parameters $\sim 100 \ \mu m$



- 2. The PID performance (from SDD & SSD)
- PID combined with stand-alone tracking allows to identify charged particles below 100 MeV/c
- p-K (3σ) separation up to 1 GeV/c
- π -K (3 σ) separation up to 600 MeV/c
- dE/dx resolution of about 10-15% is achieved



ALI-PERF-2731





1. Increase vertex resolution by a factor of ~3

Identification of secondary vertices from decaying charm and beauty

- increase statistical accuracy of channels already measured by ALICE e.g. displaced $D^0,\,J/\psi$

- measurement of new channels e.g. charmed baryon $\Lambda_{\rm c}$ or more exotic channels like $\Lambda_{\rm b}$

• measurement of baryon/meson ratios e.g. charm and beauty (Λ_c /D) (Λ_b /B)

2. Improve tracking efficiency & momentum resolution

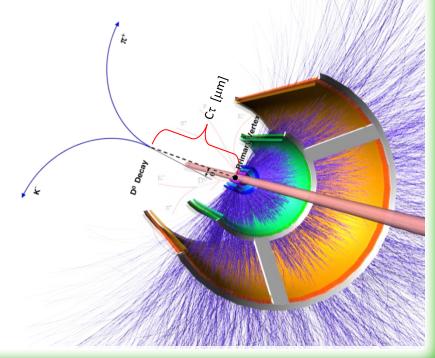
3. Improve read-out time

Target: **Pb-Pb min.bias at a rate of 50 kHz Current limitation in read-out:** ~ 1 kHz (due to SDD)

The ALICE strategy is to readout all data at a rate of 50 kHz (via min.bias Pb-Pb trigger) which will be sent to the Online Systems for processing (first reconstruction and clustercompression) and later stored on tape

Particle	Decay Channel	c τ (μm)	
D ⁰	K ⁻ π ⁺ (3.8%)	123	
D+	K⁻ π⁺ π⁺ (9.5%)	312	
D _s	K ⁺ K [−] π ⁺ (5.2%) π ⁺ π ⁺ π ⁻ (1.2%)	150	
Λ_{c}^{*}	p K⁻ π⁺ (5.0%)	59.9	

Example - Direct Topological Identification of the Open Charm



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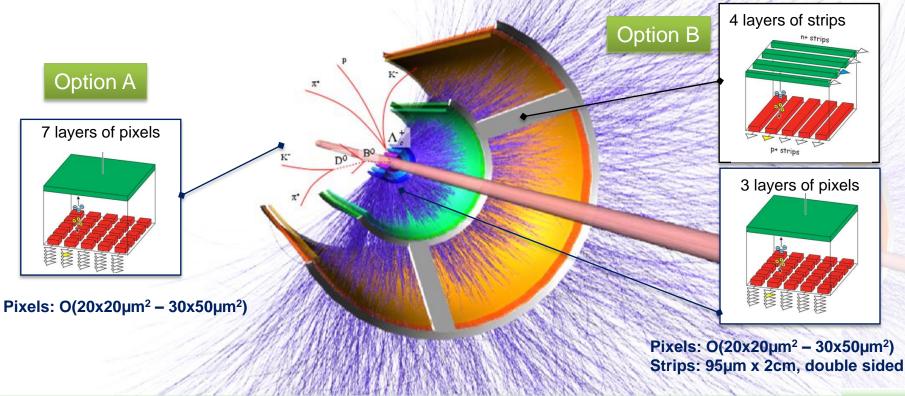


Option A: 7 layers of pixel detectors

- better standalone tracking efficiency and momentum resolution
- worse particle identification

Option B: 3 inner layers of pixel detectors and 4 outer layers of strip detectors

- worse standalone tracking efficiency and momentum resolution
- better particle identification



The ITS Upgrade proposal - Conceptual Design 🖗

	Lay	ers 6, 7			
	Layers	1 2 3		Front a	bsorber
Support cone					
	Layer / Type	<i>r</i> [cm]	±z [cm]	Intrinsic resolution $[\mu m]$ $r\phi$ z	Material budget X/X_0 [%]
	D	20		., ~	0.02

Beam	pip	e: r	~1	.98
------	-----	------	----	-----

Layer / Type	/ [cm]	±ζ [cm]	rø	$\frac{z}{z}$	X/X_0 [%]
Beam pipe	2.0	-	1	-	0.22
1 / new pixel	2.2	11.2	4	4	0.30
2 / new pixel	2.8	12.1	4	4	0.30
3 / new pixel	3.6	13.4	4	4	0.30
4 / new pixel (strip)	20.0	39.0	4(20)	4(830)	0.30 (0.83)
5 / new pixel (strip)	22.0	41.8	4(20)	4 (830)	0.30 (0.83)
6 / new pixel (strip)	41.0	71.2	4(20)	4 (830)	0.30 (0.83)
7 / new pixel (strip)	43.0	74.3	4(20)	4 (830)	0.30 (0.83)

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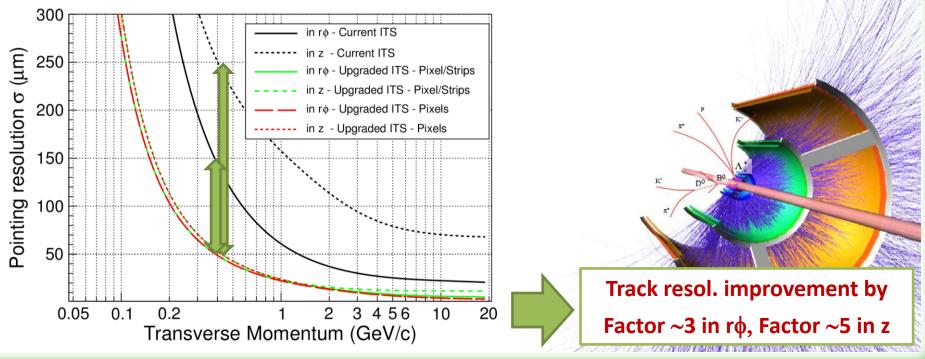
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- Add high-resolution pixel layer closer to IP, r=2.2 cm (⇒ currently r=3.9cm)
- Pixel size ~20-30 μm (rφ,z), **σ(rφ,z) ~4-6 μm**
- Material budget 0.3-0.5% X0 per layer
- (\Rightarrow currently σ (r ϕ ,z)=(12,100) μ m)
 - (\Rightarrow currently ~ 1.14%X0)

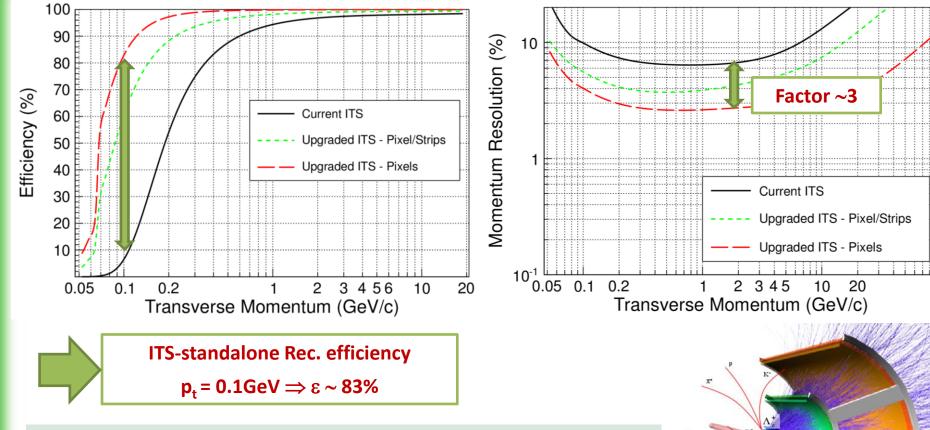
- Power consumption 300-500 mW/cm²
- Radiation tolerant design (innermost layer) compatible with 1 Mrad / 1.6x10¹³ neq over approximately 5 years





ITS Upgrade - key improvements





- Hit density of approx. 100 tracks/cm² in HI collisions
- Up to 7 silicon layers (r=2.2-50 cm) to cover from IP to TPC
- 3 innermost layers made of pixels
- outer 4 layers either pixels or double sided strips



Pixel Technologies: the choices



Key requirements

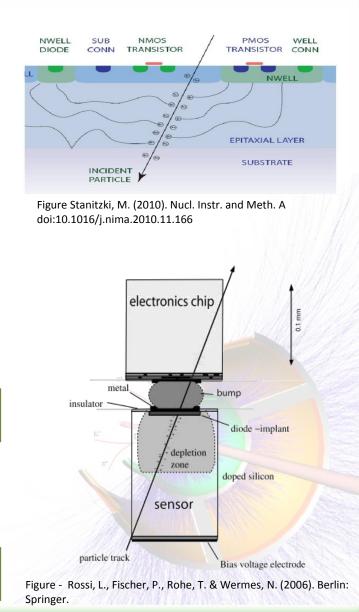
- Pixel size ~ 20-30 μ m (r ϕ ,z) $\Rightarrow \sigma$ (r ϕ ,z) ~ 4-6 μ m
- Material budget 0.3-0.5% X0 per layer
- Radiation hardness 1 Mrad / 1.6x10¹³ neq
- Power consumption 300-500 mW/cm²
- Read-out speed up to 50 kHz
- Integration time, cost ...

Monolithic pixels

- o 1 component, sensing layer included in the CMOS chip
 - Pros: material thickness and cost
 - Cons: radiation hardness and read-out speed

Hybrid pixels

- 2 components: CMOS chip and high-resistivity sensor connected via bump bonds
 - Pros: radiation hardness and speed
 - Cons: material thickness, power and cost



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R&D

R&D



Pixel Technologies: the choices



Development for Monolithic Detectors

using Tower/Jazz 0.18 µm CMOS technology ...

- Improved **TID resistance** due to smaller technology node •
- Available with high resistivity (~1 k Ω cm) epitaxial layer up to 18 μ m thick •
- Quadruple-well technology deep p-well allow the use of PMOS transistors • within the pixel cell without reducing the charge collection efficiency

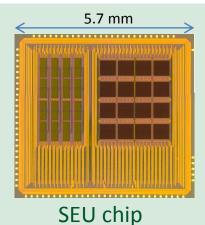
Prototype development in 2011/2012

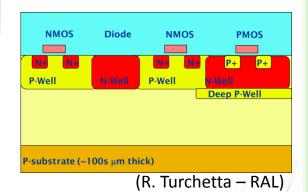
to evaluate radiation tolerance and charge collection efficiency

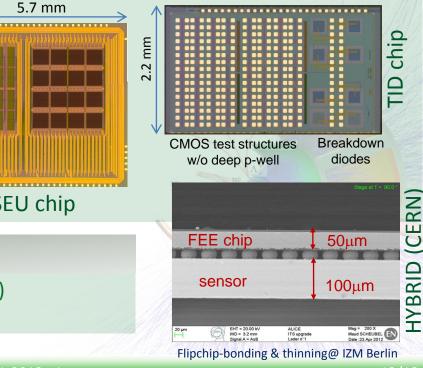
- MIMOSA32 .
- SEU chip, TID test structures •
- test matrices .

Development for Hybrid Detectors

Edgeless sensors $(100\mu m)$ + front-end chip $(50\mu m)$ in 130 nm CMOS









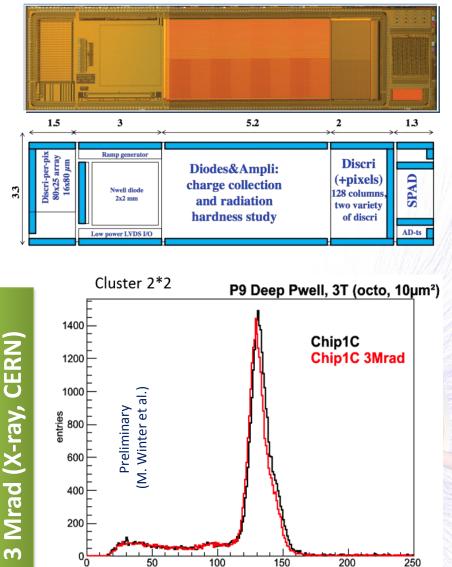


MIMOSA 32 (IPHC Strasbourg)

- Digital and analog blocks (2T and 3T structures with various diodes)
- 100 circuits delivered Jan 2012 🗸
- Test with Fe⁵⁵ source 🗸
- Irradiation tests (X-ray, neutron) ✓
- Test-Beam on the June 6-11, 2012 ✓

Charge Collection Efficiency (CCE) for 20x20 μm² pixels

- Seed pixel: ~40-50%
- 2x2 pixel cluster: nearly 100 %



ADC counts

0

ID test: irradiation



Pixel Technologies: 0.18µm CMOS

SNR ~ 32.3 ± 1.0



1078

43.77

29.43

67.11 / 77

295.2 ± 13.1

26.04 ± 0.50

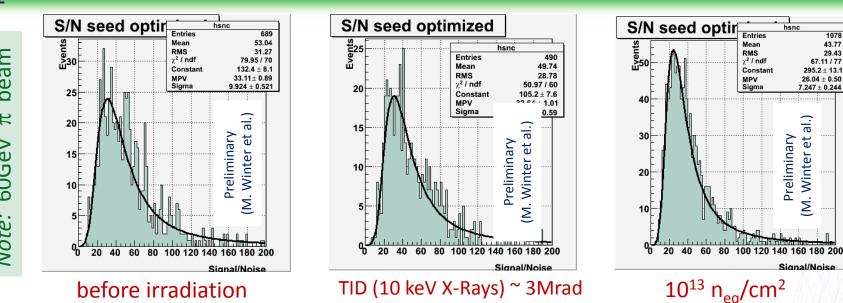
7.247 ± 0.244

al.)

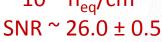
Signal/Noise

Preliminary M. Winter et





SNR ~ 33.1 ± 0.9



Summary of first Evaluation of 0.18 µm CMOS technology

- Very low noise (ENC \sim 15-20 e) and good S/N (>25)
- Charge collection almost 100 % for clusters sizes of 2x2
- No significant degradation when irradiated at 3 Mrad, 10¹³ neg

MONALICET1 (CERN/CCNU)

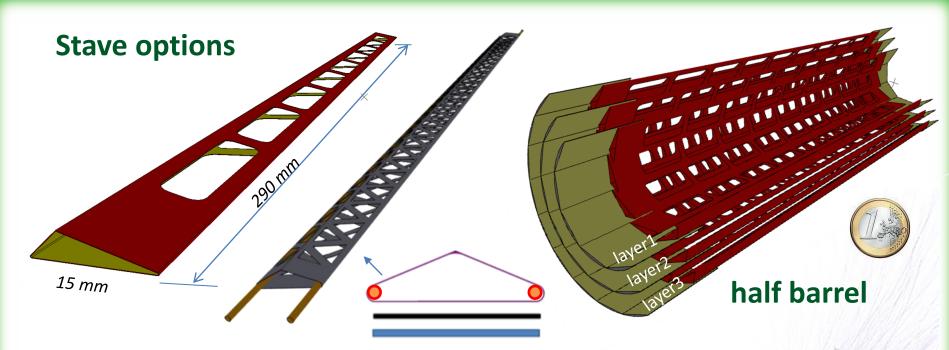
- Single transistors, memories, shift registers
- Delivery early July 2012
 / -> irradiation tests and analysis is ongoing

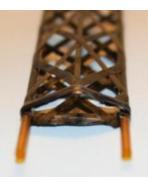
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encouraging results

Ultra-light mechanical support structure







Complete ladder prototype: two mechanical structure and cooling concepts + electrical bus + glue + dummy silicon

Material	Surface	Tickness	X ₀	X/X ₀	Contribution to the	
Wateria	(%)	(µ m)	(%)	(%)	total X/X ₀ (%)	
CFRP filament	53	190	25	0.04	15.4	
Polyimide Tubes	19	70	28.6	0.005	1.8	
Water	19	1450	36.1	0.06	22.7	
Glue (CFRP - silicon)	25	100	44.4	0.006	2.2	
Silicon	100	50	9.36	0.054	20.5	
Glue (silicon - bus)	100	100	44.4	0.022	8.6	
Electrical bus	100	-	-	0.075	28.8	
Total		≈ 0.26				

Allows $X/X_0 \le 0.3\%$

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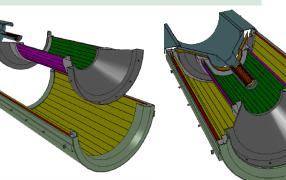
Ongoing R&D ...



- Evaluation of different mechanical structure geometries, composite materials (CFRP) and production processes
- Several ultra-light mechanical structures (ladders) for first 3 inner layers have been realized (ladder weight 0.6-1.4 g)

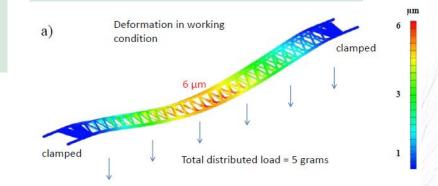


Installation considerations



Stiffness tests show very high mechanical stability

- Load of 5g : sag < 6mm
- Natural freq. ~600Hz)



Surveying several Cooling options

- Silicon micro-channel

- Polyimide tubes

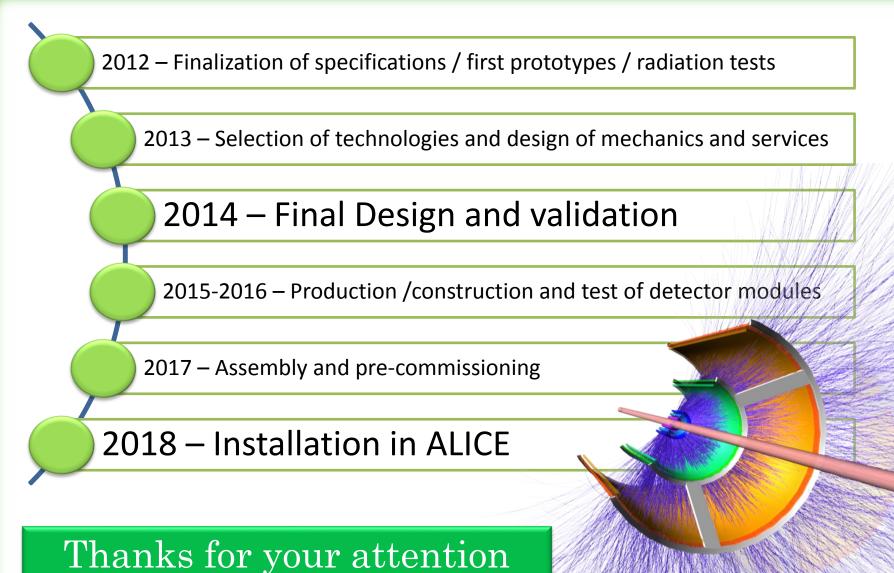
- Polyimide micro-channels
- Achieved: working temp. < 30 deg temp. gradient < 5 deg















Read-out architectures under study

"In principle, always a trade-of between speed and power consumption"

Rolling-Shutter read-out

Backup

- Pixel matrix is scanned row-by-row
- 100 μs is achieved by state-of-art sensors
- Estimate: 25 μs can be achieved at power consumption of < 800 mW/cm²

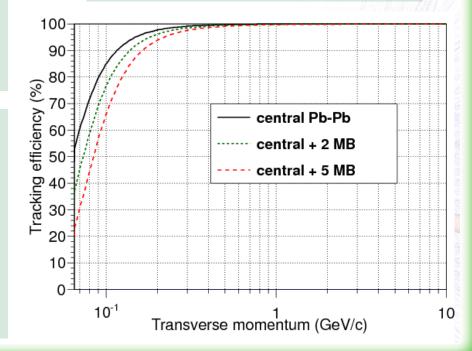
Data driven read-out (e.g. via priority encoding)

- Only signals above certain threshold transfer data to chip periphery
- Estimate (assuming 256x512 pixels): 1 μs can be achieved at a power consumption of < 30 mW/cm²

At 50kHz for Pb-Pb, in average

- + 1 pile-up events for 20 μs
- + 2 pile-up events for 50 μs

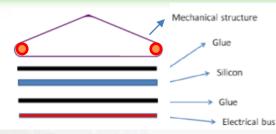
If read-out is faster than 20 μs, no significant degradation of tracking efficiency is observed





R&D on mechanical structure





Backup

Ladder prototype equipped with dummy components



Material	Surface	Tickness	X ₀	X/X ₀	Contribution to the	
Iviateriai	(%)	(µm)	(%)	(%)	total X/X ₀ (%)	
CFRP filament	53	190	25	0.04	15.4	
Polyimide Tubes	19	70	28.6	0.005	1.8	
Water	19	1450	36.1	0.06	22.7	
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Electrical bus	100	-	-	0.075	28.8	
Total		≈ 0.26				

Some examples of physics performance (Λ_c)

GeV/c

0

4

V

đ

ν

0

N

2.05

 $(X/X_{n}=0.3\%, \sigma_{rot}=4 \mu m)$

Invariant Mass (K π) [GeV/c²]

PbPb√s_{NN}=2.76 TeV

 $0.0 < p_{\star}^{D^{\circ}} < 2.0 \text{ GeV/c}$

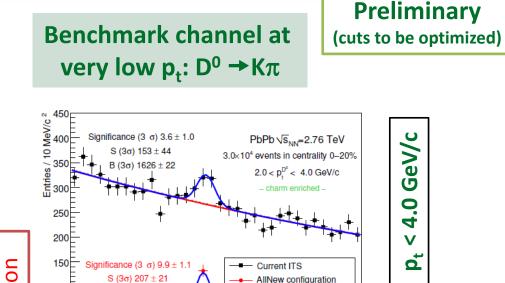
- charm enriched -

1.5×10⁵ events in centrality 0-20%

1.95

1.95





1.85

1.9

B (3σ) 231±8

1.8

Significance (3 o) 8.9 ± 1.1

 $S(3\sigma) 456 \pm 54$

B (3σ) 2177 ± 25

AllNew configuration

1.8

(X/X_=0.3%,σ_{r.o.z}=4 μm)

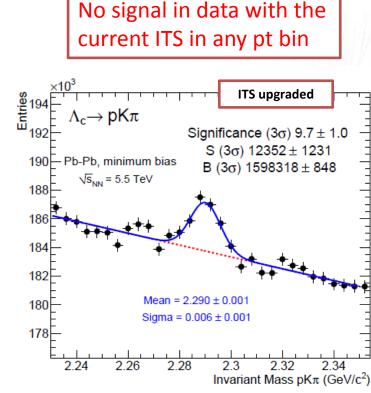
1.85

1.9

1.75

Backup

 $\Lambda c \rightarrow p K \pi$ as a benchmark case in Pb-Pb



p_t > 4.0 GeV/c

GeV/c 178 0 N V **ITS upgraded** đ 2.05 Invariant Mass (K π) [GeV/c²]

rejection background .⊆ ഹ 2 Factor

100

50

1000

900

800

600

500

400

300 E

200

100 0 E

1.75

Entries / 10 MeV/c

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$\Lambda_{c} \rightarrow pK\pi$ as a benchmark case in p-p

Comparison between current and new ITS in the same p_T bin ($p_T > 3$ GeV/c)

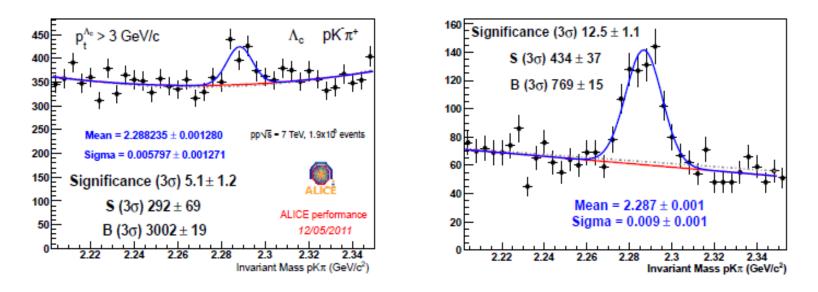


Fig. 1. – Left: Invariant mass spectrum $M[pK\pi]$ in p-p collisions at 7 TeV for $p_T > 3GeV/c^2$ in data. Right: The invariant mass spectrum obtained with the ITS Upgrade in $AllNew - 0.3 - 4\mu\%$ configuration.

Even more examples of physics performance (D⁰)



D⁰ : prompt and from B decays

Backup

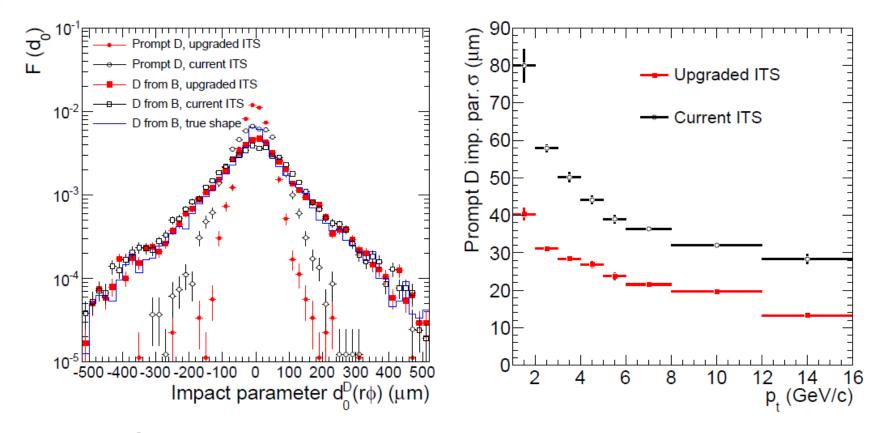


Figure 2.27: D^0 from *B* decays. Left: comparison of the impact parameter distributions for prompt and secondary D^0 obtained with the current and upgrade ITS configurations in the transverse momentum range $2 < p_t < 3 \text{ GeV}/c$. Right: sigma of the Gaussian term of the detector resolution function, representing the D^0 impact parameter resolution, for current and upgrade ITS scenarios.